

<b>Notice of References Cited</b>	Application/Control No. 10/653,199	Applicant(s)/Patent Under Reexamination FUJII, YUKIO	
	Examiner Aaron M. Dunwoody	Art Unit 3679	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,740,175	05-2004	Kitano, Shuhei	148/328
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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**NON-PATENT DOCUMENTS**

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